



Shenzhen Tuofeng Semiconductor Technology Co., Ltd

**N - CHANNEL ENHANCEMENT MODE POWER MOSFET****TF040N03N****• General Description**

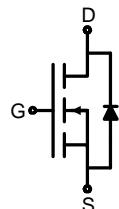
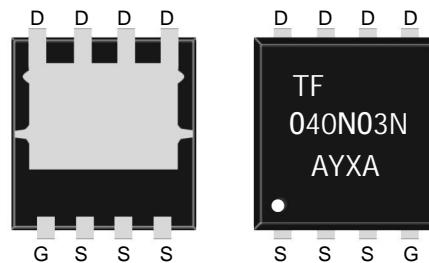
The TF040N03N combines advanced trench MOSFET technology with a low resistance package to provide extremely low  $R_{DS(ON)}$ . This device is ideal for load switch and battery protection applications.

**• Features**

- Advance high cell density Trench technology
- Low  $R_{DS(ON)}$  to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

**• Application**

- MB/VGA Vcore
- SMPS 2<sup>nd</sup> Synchronous Rectifier
- POL application
- BLDC Motor driver

**• Product Summary** $V_{DS} = 30V \quad I_D = 80A$  $R_{DS(on)(10V\ typ)} = 4.3m\Omega$  $R_{DS(on)(4.5V\ typ)} = 6.1m\Omega$ **PDFNWB5x6-8L****• Ordering Information:**

Part NO.	TF040N03N
Marking 1	040N03N
Marking 2	TF:tuofeng; AA:device code; Y:year code; X:Week
MOQ	5000

**• Absolute Maximum Ratings ( $T_C = 25^\circ C$ )**

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	$V_{DS}$	30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current	$I_D @ T_C = 25^\circ C$	80	A
	$I_D @ T_C = 75^\circ C$	60	A
	$I_D @ T_C = 100^\circ C$	50	A
Pulsed Drain Current <sup>①</sup>	$I_{DM}$	230	A
Total Power Dissipation	$P_D @ T_C = 25^\circ C$	50	W
Total Power Dissipation	$P_D @ T_A = 25^\circ C$	2.0	W
Operating Junction Temperature	$T_J$	-55 to 150	$^\circ C$
Storage Temperature	$T_{STG}$	-55 to 150	$^\circ C$

Note: ① Pulse Test : Pulse width  $\leq 300\mu s$ , Duty cycle  $\leq 2\%$  ;



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## N - CHANNEL ENHANCEMENT MODE POWER MOSFET

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Single Pulse Avalanche Energy	$E_{AS}$	150	mJ
Avalanche Current	$I_{AS}$ $I_{AR}$	30	A

## •Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	$R_{thJC}$	-	-	3.5	° C/W
Thermal resistance, junction - ambient	$R_{thJA}$	-	-	55	° C/W
Soldering temperature, wave soldering for 8s	$T_{sold}$	-	-	265	° C

## •Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Drain-Source Breakdown Voltage	$BV_{DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	30			V
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{GS} = V_{DS}, I_D = 250\mu A$	1.0	1.7	2.5	V
Drain-Source Leakage Current	$I_{DSS}$	$V_{DS} = 30V, V_{GS} = 0V$			1.0	$\mu A$
Gate- Source Leakage Current	$I_{GSS}$	$V_{GS} = \pm 20V, V_{DS} = 0V$			$\pm 100$	nA
Static Drain-source On Resistance	$R_{DS(ON)}$	$V_{GS} = 10V, I_D = 30A$		4.3	5.0	$m\Omega$
		$V_{GS} = 4.5V, I_D = 20A$		6.1	7.5	$m\Omega$
Forward Transconductance	$g_{FS}$	$V_{DS} = 25V, I_D = 10A$		22		S
Source-drain voltage	$V_{SD}$	$I_S = 20A$			1.20	V

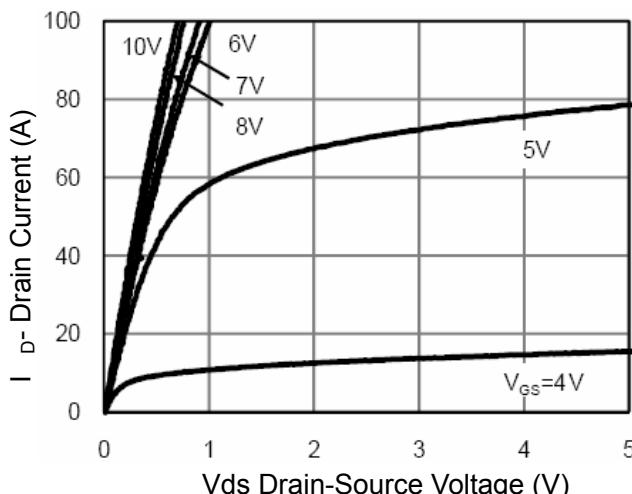
## •Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Input capacitance	$C_{iss}$	$V_{DS} = 15V, V_{GS} = 0V$ $f = 1MHz$	-	1615	-	pF
Output capacitance	$C_{oss}$		-	245	-	
Reverse transfer capacitance	$C_{rss}$		-	216	-	

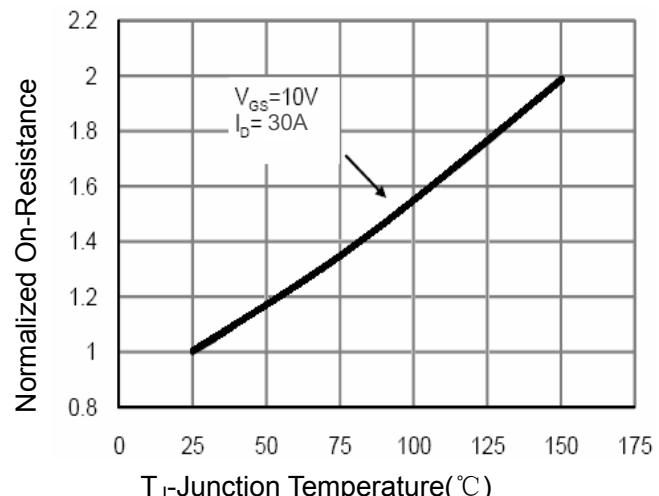
•Gate Charge characteristics( $T_a = 25^\circ C$ )

Parameter	Symbol	Condition	Min.	Typ	Max.	Unit
Gate Resistance	$R_g$	$f = 1MHz$		2.1		$\Omega$
Total gate charge	$Q_g$	$V_{DD} = 15V$	-	42	-	nC
Gate - Source charge	$Q_{gs}$		-	4.0	-	
Gate - Drain charge	$Q_{gd}$		-	14	-	
Turn-ON Delay time	$t_{D(on)}$	$V_{GS} = 10V, V_{DS} = 15V$ $R_G = 3.0\Omega, I = 20A$		7.5		ns
Turn-ON Rise time	$t_r$			14.5		ns
Turn-Off Delay time	$t_{D(off)}$			35		ns
Turn-Off Fall time	$t_f$			9.6		ns

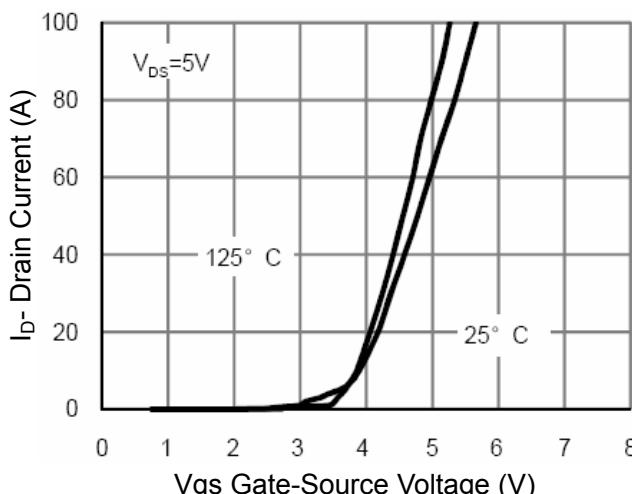
**Typical Electrical and Thermal Characteristics**



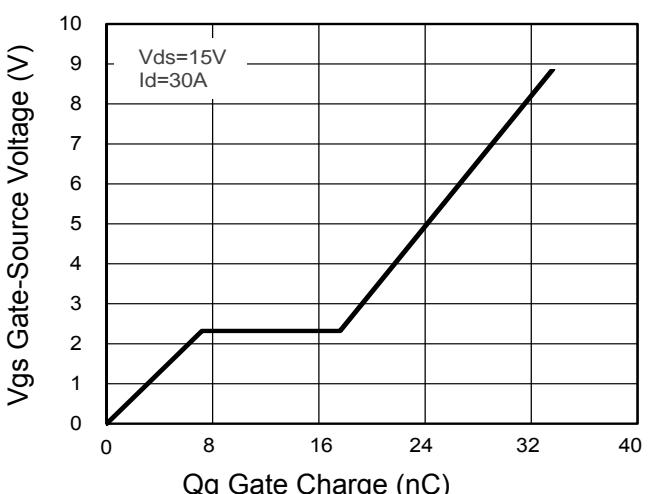
**Figure 1 Output Characteristics**



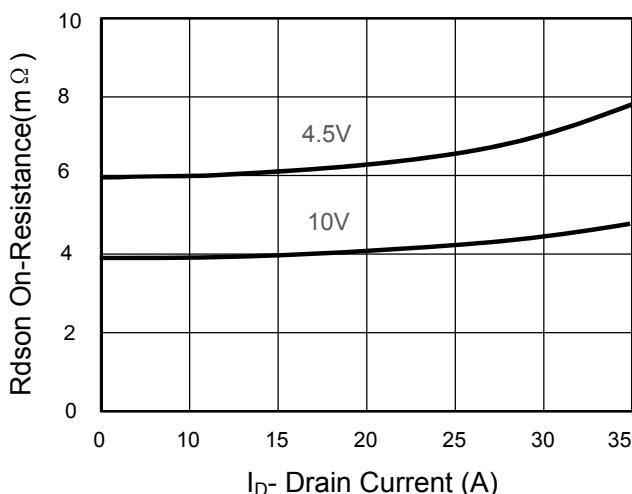
**Figure 4 Rdson-JunctionTemperature**



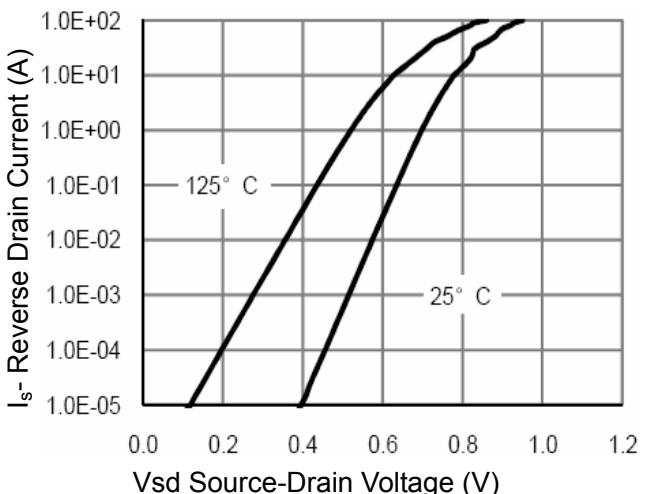
**Figure 2 Transfer Characteristics**



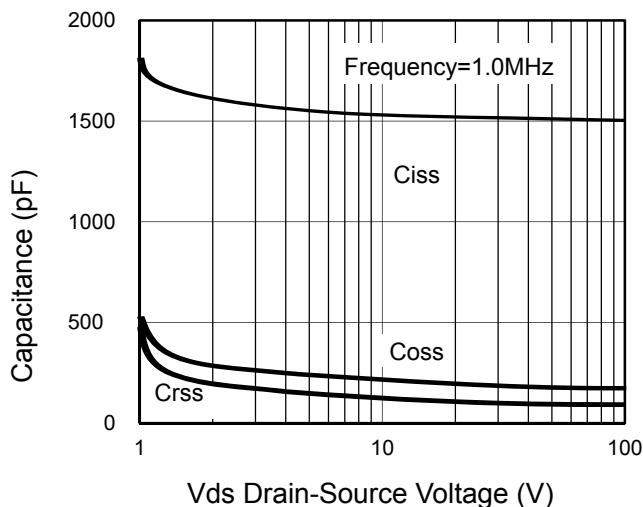
**Figure 5 Gate Charge**



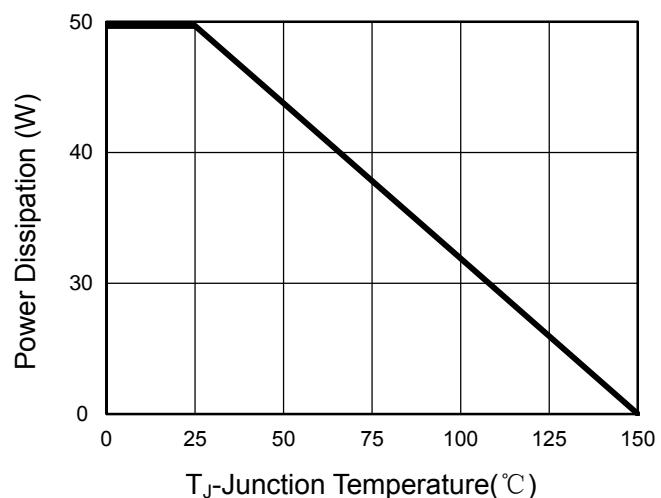
**Figure 3 Rdson- Drain Current**



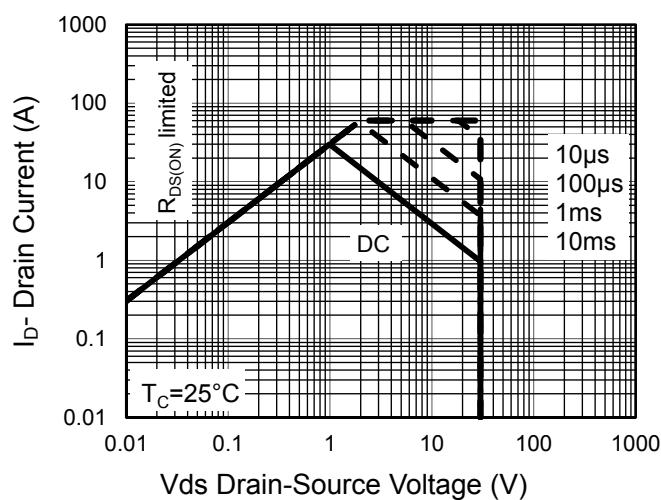
**Figure 6 Source- Drain Diode Forward**



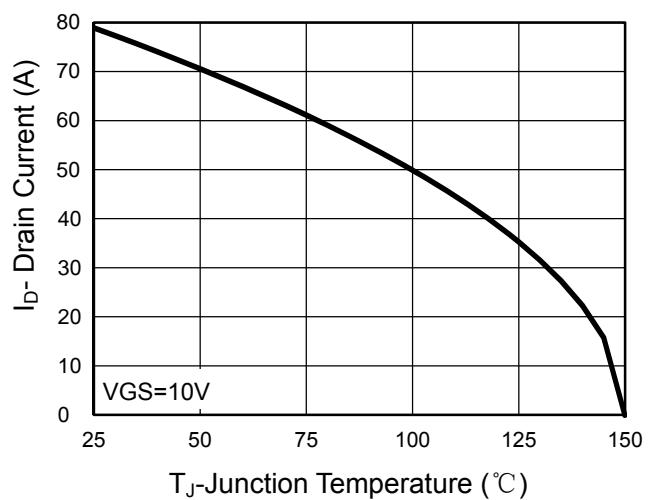
**Figure 7 Capacitance vs Vds**



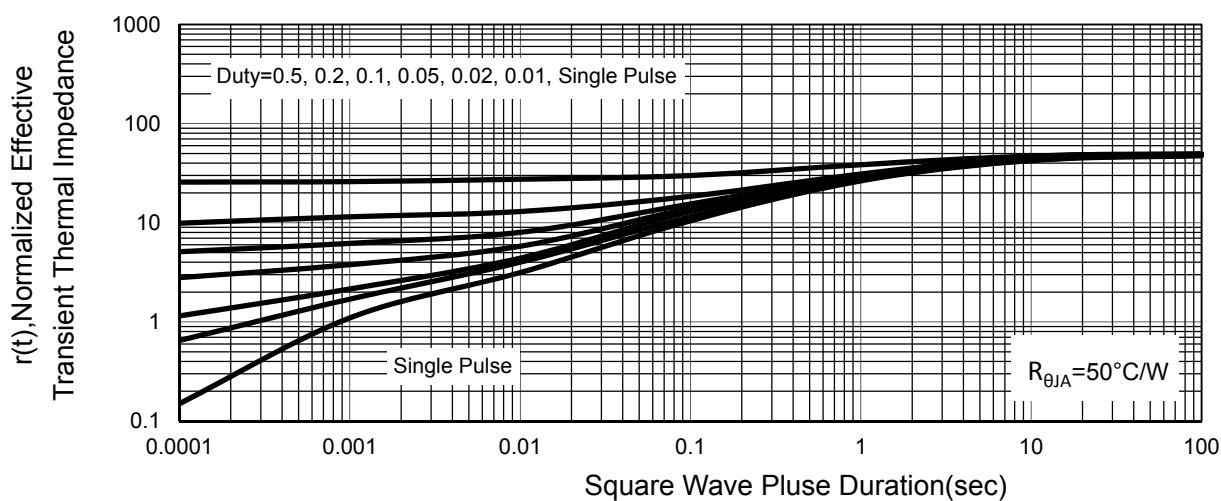
**Figure 9 Power De-rating**



**Figure 8 Safe Operation Area**



**Figure 10 Current De-rating**



**Figure 11 Normalized Maximum Transient Thermal Impedance**

Fig.12 Switching Time Measurement

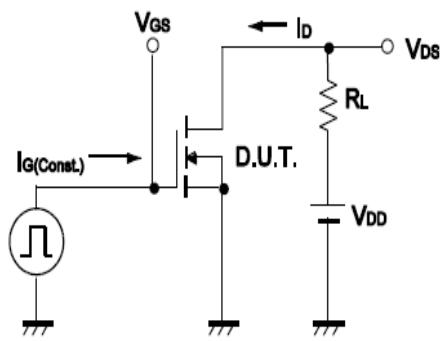
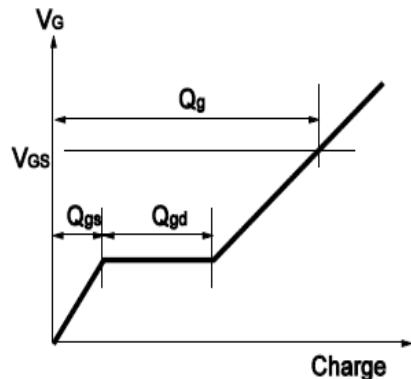


Fig.13 Gate Charge Waveform



Circuit Fig.14 Switching Time

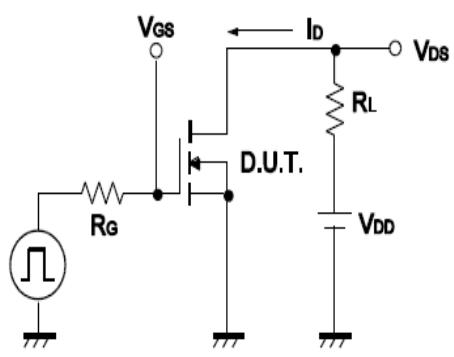
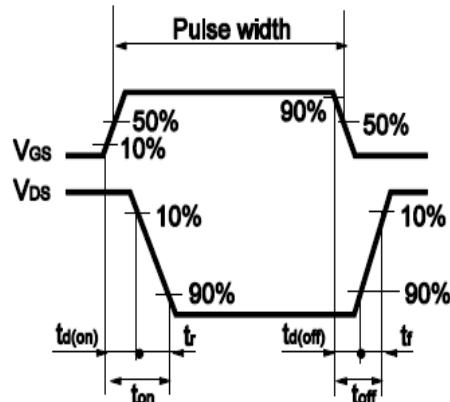


Fig.15 Gate Charge Waveform



Measurement Circuit

Fig.16 Avalanche Measurement Circuit

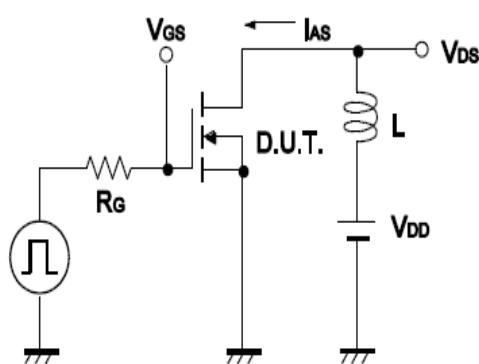
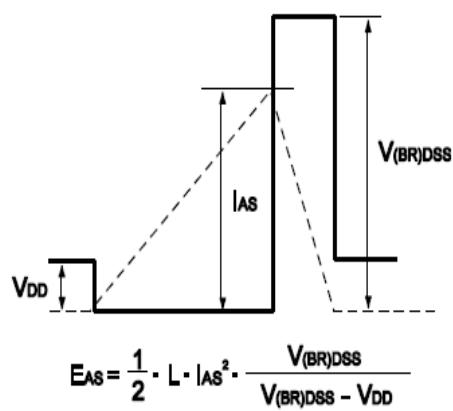


Fig.17 Avalanche Waveform



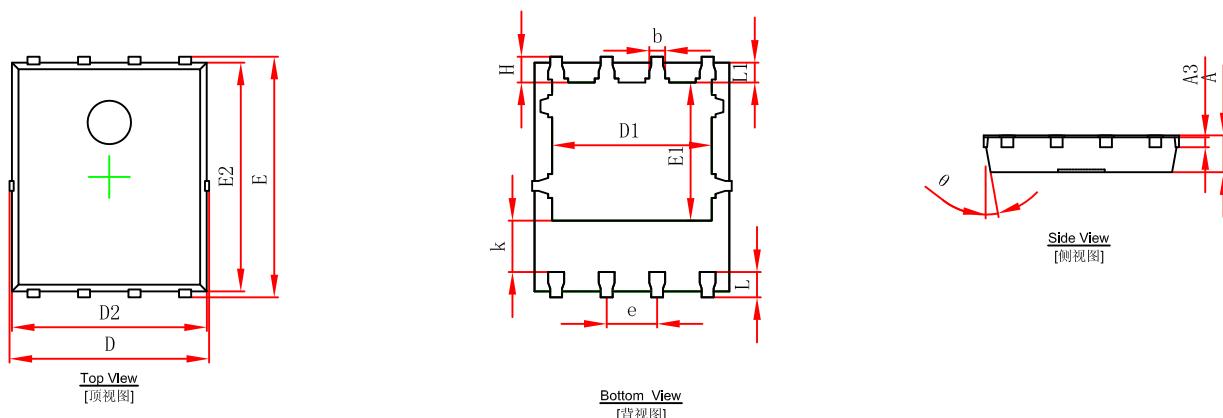


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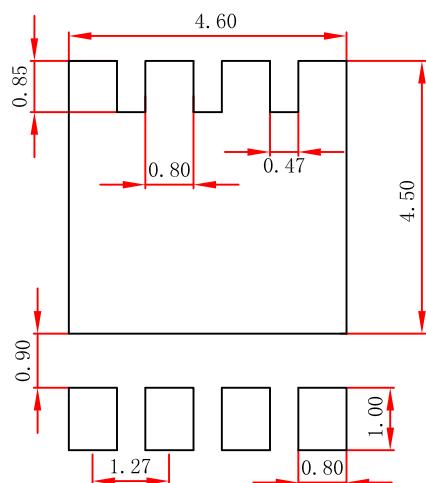
TF040N03N

## PDFNWB5x6-8L Package Outline Dimensions



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039
A3	0.254REF.		0.010REF.	
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	3.910	4.110	0.154	0.162
E1	3.375	3.575	0.133	0.141
D2	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
e	1.270TYP.		0.050TYP.	
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
H	0.574	0.726	0.023	0.029
θ	10°	12°	10°	12°

## PDFNWB5x6-8L Suggested Pad Layout



## Note:

1. Controlling dimension: in millimeters.
2. General tolerance:  $\pm 0.05\text{mm}$ .
3. The pad layout is for reference purposes only.